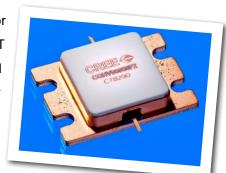


CGHV96050F2

50 W, 7.9 - 9.6 GHz, 50-ohm, Input/Output Matched GaN HEMT

Cree's CGHV96050F2 is a gallium nitride (GaN) High Electron Mobility Transistor (HEMT) on Silicon Carbide (SiC) substrates. This GaN Internally Matched (IM) FET offers excellent power added efficiency in comparison to other technologies. GaN has superior properties compared to silicon or gallium arsenide, including higher breakdown voltage, higher saturated electron drift velocity and higher thermal conductivity. GaN HEMTs also offer greater power density and wider bandwidths compared to GaAs transistors. This IM FET is available in a metal/ceramic flanged package for optimal electrical and thermal performance.



PN: CGHV96050F2 Package Type: 440217

Typical Performance Over 8.4-9.6 GHz (T_c = 25°C)

Parameter	8.4 GHz	8.8 GHz	9.0 GHz	9.2 GHz	9.4 GHz	9.6 GHz	Units
Linear Gain	13.8	12.8	12.3	12.3	12.2	11.8	dB
Output Power	85	77	81	82	75	75	W
Power Gain	10.4	9.9	10.1	10.1	9.8	9.8	dB
Power Added Efficiency	57	54	52	54	48	45	%

Note: Measured in CGHV96050F2-AMP (838179) under 100 uS pulse width, 10% duty, Pin 39.0 dBm (7.9 W)

Features

- 8.4 9.6 GHz Operation
- 80 W P_{OUT} typical
- 10 dB Power Gain
- 55 % Typical PAE
- 50 Ohm Internally Matched
- <0.1 dB Power Droop

Applications

- · Marine Radar
- Weather Monitoring
- Air Traffic Control
- Maritime Vessel Traffic Control
- Port Security

Large Signal Models Available for ADS and MWO



Absolute Maximum Ratings (not simultaneous)

Parameter	Symbol	Rating	Units	Conditions
Drain-source Voltage	V _{DSS}	100	Volts	25°C
Gate-source Voltage	$V_{\sf GS}$	-10, +2	Volts	25°C
Power Dissipation	P _{DISS}	57.6 / 86.4	Watts	(CW / Pulse)
Storage Temperature	T _{stg}	-65, +150	°C	
Operating Junction Temperature	T _J	225	°C	
Maximum Drain Current	I _{DMAX}	6	Amps	
Maximum Forward Gate Current	I _{GMAX}	14.4	mA	25°C
Soldering Temperature ¹	T _s	245	°C	
Screw Torque	τ	40	in-oz	
Thermal Resistance, Junction to Case	$R_{\scriptscriptstyle{\theta JC}}$	1.40	°C/W	Pulse Width = 100 μ s, Duty Cycle = 10%, P_{DISS} = 86.4 W
Thermal Resistance, Junction to Case	$R_{\theta JC}$	2.12	°C/W	CW, 85° C, $P_{DISS} = 57.6 \text{ W}$
Case Operating Temperature ³	T _c	-40, +125	°C	

Note:

Electrical Characteristics (Frequency = 9.6 GHz unless otherwise stated; T_c = 25°C)

Characteristics	Symbol	Min.	Тур.	Max.	Units	Conditions
DC Characteristics ¹						
Gate Threshold Voltage	V _{GS(TH)}	-3.8	-3.0	-2.3	V	V _{DS} = 10 V, I _D = 14.4 mA
Gate Quiscent Voltage	$V_{_{\mathrm{Q}}}$	-	-3.0	-	V	$V_{DS} = 40 \text{ V, I}_{D} = 500 \text{ mA}$
Saturated Drain Current ²	I _{DS}	11.5	13.0	-	А	$V_{DS} = 6.0 \text{ V}, V_{GS} = 2.0 \text{ V}$
Drain-Source Breakdown Voltage	V _{BD}	100	-	-	٧	$V_{GS} = -8 \text{ V, I}_{D} = 14.4 \text{ mA}$
RF Characteristics ³	RF Characteristics ³					
Small Signal Gain	S21	10.0	11.8	-	dB	$V_{DD} = 40 \text{ V, } I_{DQ} = 500 \text{ mA, } P_{IN} = -20 \text{ dBm}$
Input Return Loss 1	S11	-	-5.2	-2.1	dB	$V_{\rm DD}$ = 40 V, $I_{\rm DQ}$ = 500 mA, $P_{\rm IN}$ = -20 dBm, Frequency = 8.4-9.6 GHz
Output Return Loss	S22	-	-12.3	-9.0	dB	V_{DD} = 40 V, I_{DQ} = 500 mA, P_{IN} = -20 dBm
Power Output ^{3, 4}	P _{out}	47	70	-	W	$V_{DD} = 40 \text{ V, } I_{DQ} = 500 \text{ mA, } P_{IN} = 39 \text{ dBm}$
Power Added Efficiency ^{3, 4}	PAE	32	45	-	%	V_{DD} = 40 V, I_{DQ} = 500 mA, P_{IN} = 39 dBm
Output Mismatch Stress	VSWR	-	-	5:1	Ψ	No damage at all phase angles, $V_{\rm DD}$ = 40 V, $I_{\rm DQ}$ = 500 mA,

¹ Current limit for long term reliable operation.

² Refer to the Application Note on soldering at http://www.cree.com/rf/document-library

³ See also, the Power Dissipation De-rating Curve on Page 9.

¹ Measured on-wafer prior to packaging.

² Scaled from PCM data.

³ Measured in CGHV96050F2-AMP (AD-09115) under 100 μS pulse width, 10% duty 4 Fixture loss de-embedded using the following offsets. At 9.6 GHz, input and output = 0.50 dB.



Figure 1. - Small Signal Gain and Return Loss vs Frequency of CGHV96050F2 measured in CGHV96050F2-AMP

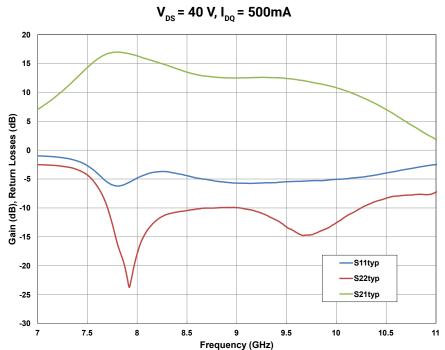
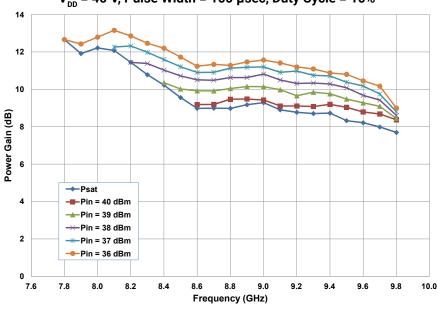


Figure 2. - Power Gain vs. Frequency and Input Power V_{DD} = 40 V, Pulse Width = 100 µsec, Duty Cycle = 10%





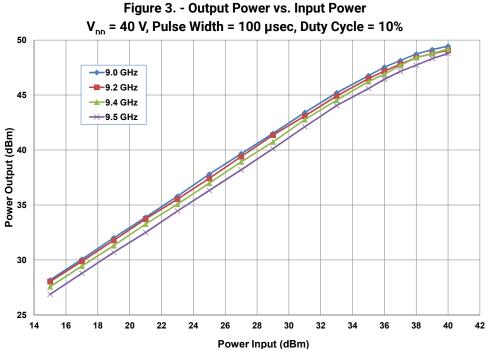


Figure 4. - Power Gain vs. Frequency and Input Power V_{DD} = 40 V, Pulse Width = 100 µsec, Duty Cycle = 10% 15 14 13 12 11 10 9 8 7 6 →-9.0 GHz 5 -9.2 GHz 4 ┷-9.4 GHz

Input Power(dBm)

Power Gain (dB)

3

2

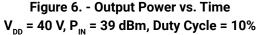
0

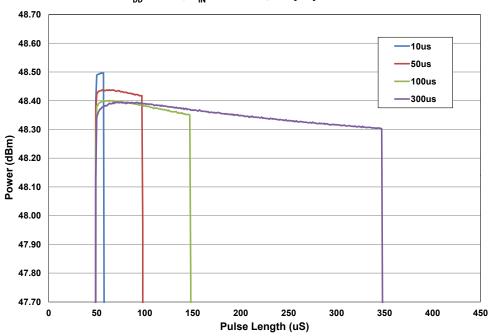
→ 9.6 GHz



60 55 →-9.0 GHz 50 ---9.2 GHz →9.4 GHz 45 → 9.6 GHz Power Added E fficiency (%) 40 25 20 15 10 5 0 20 28 14 16 18 22 40 42 Input Power (dBm)

Figure 5. - Power Added Efficiency vs. Input Power V_{DD} = 40 V, Pulse Width = 100 µsec, Duty Cycle = 10%



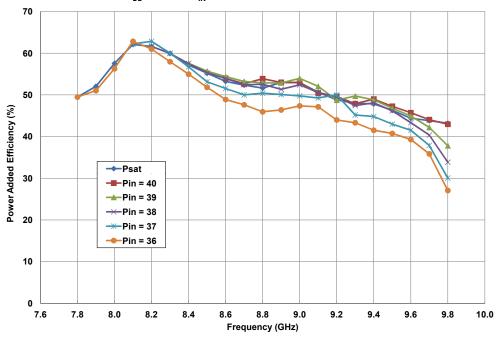




50.0 49.0 48.0 47.0 46.0 Ontbut Power (dBm) 45.0 44.0 43.0 → Psat ----Pin = 40 —Pin = 39 ——Pin = 38 **-**₩-Pin = 37 ---Pin = 36 42.0 41.0 40.0 10.0 7.6 7.8 8.0 8.2 8.4 8.8 9.0 9.4 9.6 9.8 8.6 Frequency (GHz)

Figure 7. - Output Power vs. Input Power & Frequency V_{DD} = 40 V, Pulse Width = 100 µsec, Duty Cycle = 10%

Figure 8. - Power Added Efficiency vs. Input Power & Frequency V_{DD} = 40 V, P_{IN} = 39 dBm, Duty Cycle = 10%





CGHV96050F2-AMP Demonstration Amplifier Circuit Bill of Materials

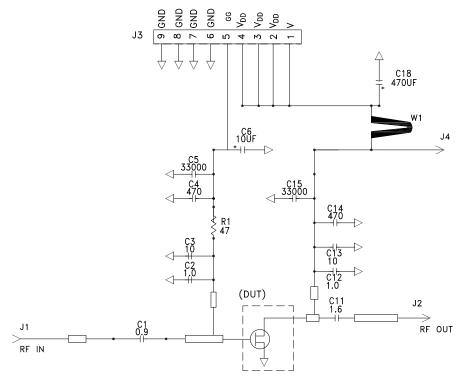
Designator	Description	Qty
R1	RES, 47 OHM, +/- 1%, 1/16W,0603	1
C1	CAP, 0.9pF, +/- 0.05pF,200V, 0402	1
C11	CAP, 1.6pF, +/- 0.1 pF,200V, 0402	1
C2, C12	CAP, 1.0pF, +/- 0.1 pF,200V, 0402	2
C3,C13	CAP, 10.0pF, +/-5%,250V, 0603,	2
C4,C14	CAP, 470PF, 5%, 100V, 0603, X	2
C5,C15	CAP,33000PF, 0805,100V, X7R	2
C6	CAP 10UF 16V TANTALUM	1
C18	CAP, 470uF, 20%, 80V, ELECT, SMD Size K	1
J1,J2	CONN,N,FEM,W/.500 SMA FLNG	2
J3	HEADER RT>PLZ .1CEN LK 9POS	1
J4	CONNECTOR; SMB, Straight, JACK,SMD	1
W1	CABLE ,18 AWG, 4.2"	1
	PCB, RF35, 2.5 X 3.0 X (0.020/0.250)	1
	TRANSISTOR, CGHV96050F2	1
	#2 SPLIT LOCKWASHER SS	4
	2-56 SOC HD SCREW 1/4 SS	4

CGHV96050F2-AMP Demonstration Amplifier Circuit

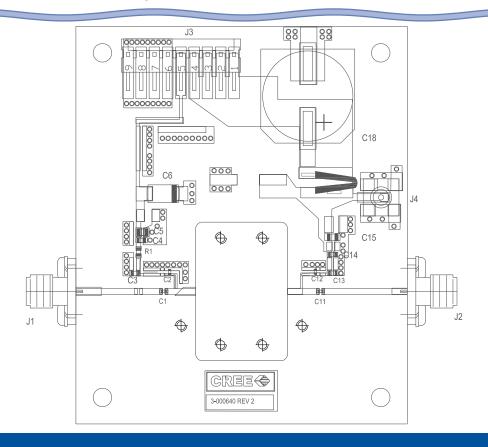




CGHV96050F2-AMP Demonstration Amplifier Circuit Schematic

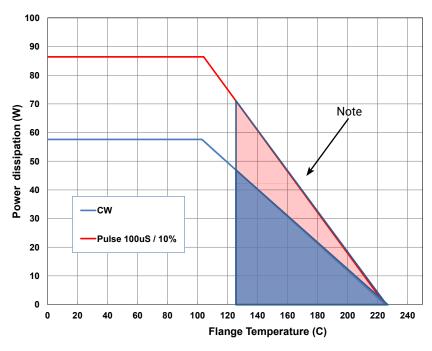


CGHV96050F2-AMP Demonstration Amplifier Circuit Outline





CGHV96050F2 Power Dissipation De-rating Curve



Note: Shaded area exceeds Maximum Case Operating Temperature (See Page 2).

Electrostatic Discharge (ESD) Classifications

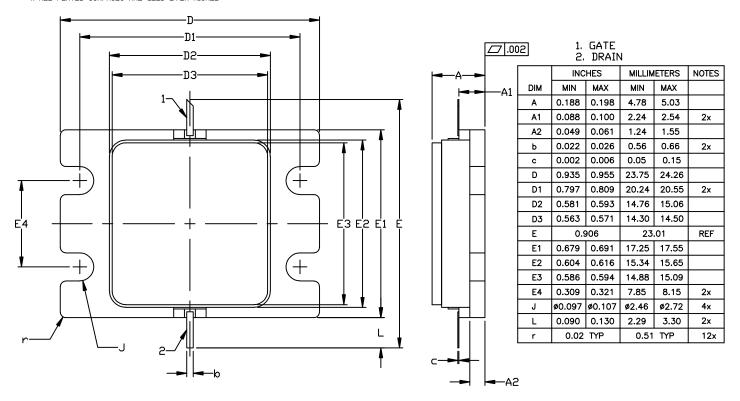
Parameter	Symbol	Class	Test Methodology
Human Body Model	НВМ	1A (> 250 V)	JEDEC JESD22 A114-D
Charge Device Model	CDM	II (200 < 500 V)	JEDEC JESD22 C101-C



Product Dimensions CGHV96050F2 (Package Type - 440217)

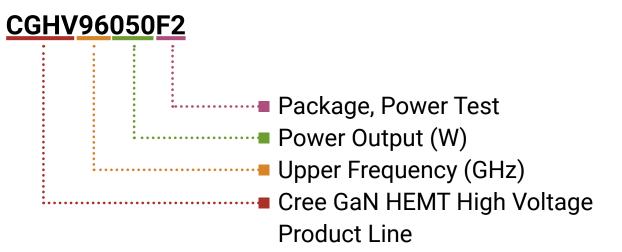
NOTES: (UNLESS OTHERWISE SPECIFIED)

- 1. INTERPRET DRAWING IN ACCURDANCE WITH ANSI Y14.5M-2009
- 2. ADHESIVE FROM LID MAY EXTEND A MAXIMUM OF .020 BEYOND EDGE OF LID
- 3. LID MAY BE MISALIGNED TO THE BODY OF PACKAGE BY A MAXIMUM OF .008 IN ANY DIRECTION
- 4. ALL PLATED SURFACES ARE GOLD OVER NICKEL





Part Number System



Parameter	Value	Units
Upper Frequency ¹	9.6	GHz
Power Output	50	W
Package	Flange	-

Table 1.

Note¹: Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Character Code	Code Value
А	0
В	1
С	2
D	3
Е	4
F	5
G	6
Н	7
J	8
K	9
Examples:	1A = 10.0 GHz 2H = 27.0 GHz

Table 2.



Product Ordering Information

Order Number	Description	Unit of Measure	Image
CGHV96050F2	GaN HEMT	Each	CRICE CONTRACTOR OF THE PARTY O
CGHV96050F2-TB	GaN HEMT	Each	
CGHV96050F2-AMP	Test board without GaN HEMT	Each	
CGHV96050F2-JMT	CGHV96050F2 Delivered in a JEDEC Matrix tray	50 parts / tray. Order multiple = 50pcs	



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